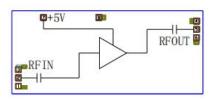


# Key features

·Freq:1.0-20.0GHz
·NF: 1.8dB
·Gain: 18dB
·Gain Flatness:±1.4dB
·OP-1dB:14dBm
·Psat Satisfaction:16dBm
·OIP3:25.5dBm
·Single power supply:+5V/71mA
·50Ω Input/Output
·Size:3.45×1.5×0.1mm<sup>3</sup>

# **Functional Diagram**



## Description

MC1086 is a low noise amplifier Chip, working at 1.0-20.0GHz, single power supply +5V work. Under 71mA current, it can provide 18dB gain and 14dBm P-1dB output power, the typical noise figure is 1.8dB.

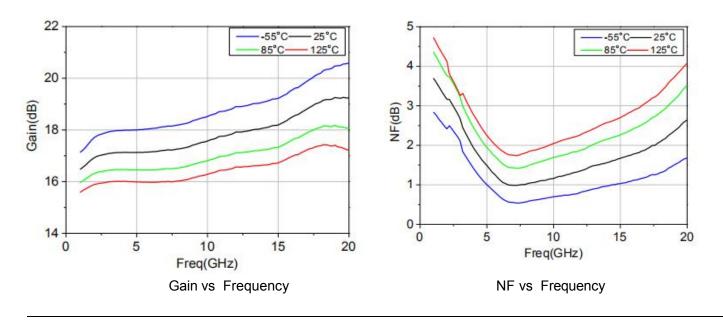
The low-noise amplifier chip adopts an onchip metallized through-hole process without additional grounding measures, and is simple and convenient to use; the back of the chip is metallized, which is suitable for conductive adhesive bonding or eutectic mounting process.

# Electrical Specifications (T<sub>A</sub>=+25°C, 50Ω system, VD=+5V, Idd=71mA)

Electrical opcom		e, com system,	D CITING II	····· •/	
Parameters	Function	Min.	Тур.	Max.	Units
Working Frequency	Freq	1.0	-	20.0	GHz
Gain	Gain	-	18	-	dB
Gain Flatness	∆ Gain	-	±1.4	-	dB
Noise Figure	NF	-	1.8	-	dB
OP-1dB	P-1dB	-	14	-	dBm
Input Return Loss	IRL	-	-17	-	dB
Output Return Loss	ORL	-	-17	-	dB
Saturated Output Power	Psat	-	16	-	dBm
Output Third Order Intercept Point	OIP3	-	25.5	-	dBm
Quiescent Current	Idd	-	71	-	mA

 $\left[1\right]\,$  The chips are 100% DC and RF tested.

# **Typical Testing Characteristics**





-55°C

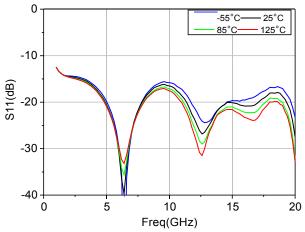
85°C

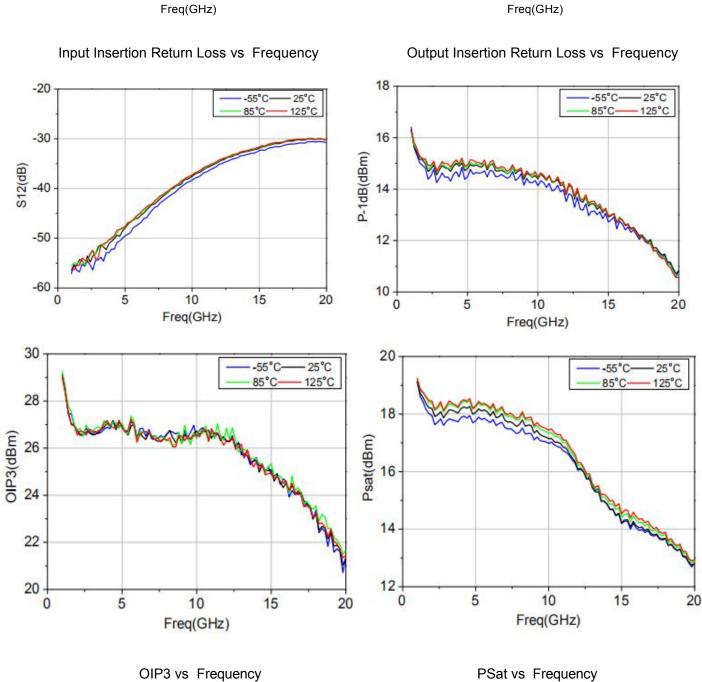
15

25°C

125°C

20





-10

-20

-30

-40

-50

0

5

10

S22(dB)



#### Absolute Maximum Ratings

Parameter Limits	Values			
Pin, 50Ω	15dBm			
Drain Voltage VD	+6V			
Storage Temperature	-65~+150℃			
Operating Temperature	-55~+125℃			
Mounting Temperature	300°C			
(30s,N <sub>2</sub> Protection)				
Exceeding the above conditions may cause permanent damage to the chip.				



This product is ESD sensitive. Proper ESD precautions shall be taken to avoid performance degradation or loss of functionality.

·Assembling in a clean environment.

- · Avoiding rapid temperature
- changes during the mounting process.
- · Do not touch the surface

or use dry /wet chemical methods to clean the surface.

·Using 2 bonding wires(shaped as figure eight

- for input and output, the bonding wires should be as short as p ossible.
- · Storing in a dry,N<sub>2</sub> protection environment.

### **Pad Description**

#### **Outline Drawing** 570 1500-±+5V 81 04 -5 -1160 +RFÖUT 📓 RFIN 290 -2-0 3450 $\cap$ Notes:

- 1. Unit:µm
- 2. Back side Metallization:Gold
- 3. Back side metal is ground
- 4. Bonding pas size: 100µm
- 5. Outline Dimensional Tolerance: $\pm 50 \mu m$

Pad No.	Function	Description	Interface Schematic
2	RFIN	RF signal input, External 50Ω system, no need for DC blocking capacitor	RFINI
5	RFOUT	RF signal Output,External 50Ω system, no need for DC blocking capacitor	LI-I-RFOUT
7	VD	Amplifier working voltage feed end, external 100pF power filter capacitor required	Ļţ vp
1, 3, 4, 6, 8	GND	Ground pressure pad for probe test	₀GND ↓
Die bottom	GND	The bottom of the chip needs to be in good contact with the RF and DC ground	₀GND Ļ

## **Assembly Diagram**

